Notice of References Cited Application/Control No. 10/644,730 Examiner Andre Pierre-Louis Applicant(s)/Patent Under Reexamination SEKIDO ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,795,802	09-2004	Yonezawa et al.	703/19
*	В	US-2005/0132306	06-2005	Smith et al.	716/001
*	С	US-2003/0229875	12-2003	Smith et al.	716/10
*	D	US-6,144,931	11-2000	Toda, Takeshi	703/13
*	E	US-2003/0237064	12-2003	White et al.	716/5
*	F	US-2002/0152447	10-2002	Venugopal et al.	716/4
	G	US-			
	н	US-			
	1	US-			
	J	US-			
-	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
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	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.